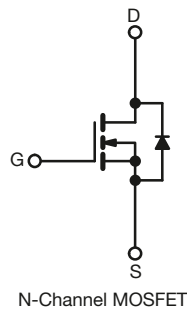
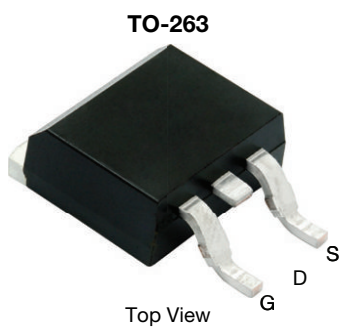


## IRFS4127TRLPBF-VB Datasheet

### N-Channel 200 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	200
R <sub>DS(on)</sub> Typ. (Ω) at V <sub>GS</sub> = 10 V	0.0076
R <sub>DS(on)</sub> Typ. (Ω) at V <sub>GS</sub> = 7.5 V	0.0086
Q <sub>g</sub> typ. (nC)	58
I <sub>D</sub> (A)	100
Configuration	Single



#### FEATURES

- ThunderFET® power MOSFET
- Maximum 175 °C junction temperature
- 100 % R<sub>g</sub> and UIS tested



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

#### APPLICATIONS

- Power supplies:
  - Uninterruptible power supplies
  - AC/DC switch-mode power supplies
  - Lighting
- Synchronous rectification
- DC/DC converter
- Motor drive switch
- DC/AC inverter
- Solar micro inverter
- Class D audio amplifier

ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V <sub>DS</sub>	200	V
Gate-source voltage		V <sub>GS</sub>	± 20	
Continuous drain current	T <sub>C</sub> = 25 °C	I <sub>D</sub>	100	A
	T <sub>C</sub> = 125 °C		62	
Pulsed drain current (t = 100 μs)		I <sub>DM</sub>	300	
Continuous source-drain diode current		I <sub>S</sub>	100	
Single pulse avalanche current <sup>a</sup>	L = 0.1 mH	I <sub>AS</sub>	60	
Single pulse avalanche energy <sup>a</sup>		E <sub>AS</sub>	180	mJ
Maximum power dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	375 <sup>b</sup>	W
	T <sub>C</sub> = 125 °C		125 <sup>b</sup>	
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Soldering recommendations (peak temperature) <sup>c</sup>			260	

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	MAXIMUM	UNIT
Maximum junction-to-ambient (PCB mount) <sup>c</sup>		R <sub>thJA</sub>	40	°C/W
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	0.4	

#### Notes

- Duty cycle ≤ 1 %.
- See SOA curve for voltage derating.
- When mounted on 1" square PCB (FR4 material).
- Package limited.

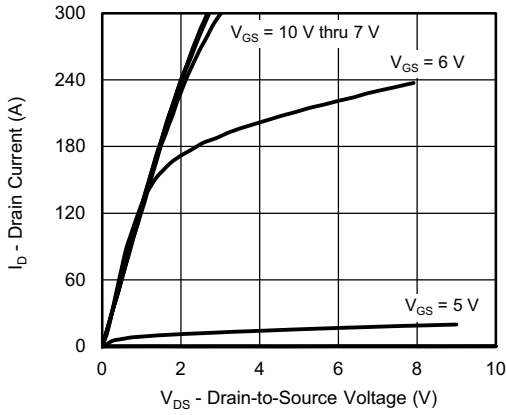
<b>SPECIFICATIONS</b> ( $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
<b>Static</b>						
Drain-source breakdown voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	200	-	-	V
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	2	-	4	V
Gate-source leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	-	-	250	nA
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = 200\text{ V}, V_{GS} = 0\text{ V}$	-	-	1	$\mu\text{A}$
		$V_{DS} = 200\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$	-	-	150	
		$V_{DS} = 200\text{ V}, V_{GS} = 0\text{ V}, T_J = 175\text{ }^\circ\text{C}$	-	-	5	mA
On-state drain current <sup>a</sup>	$I_{D(on)}$	$V_{DS} \geq 10\text{ V}, V_{GS} = 10\text{ V}$	60	-	-	A
Drain-source on-state resistance <sup>a</sup>	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 40\text{ A}$	-	0.0076	-	$\Omega$
		$V_{GS} = 7.5\text{ V}, I_D = 40\text{ A}$	-	0.0086	-	
Forward transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 15\text{ V}, I_D = 40\text{ A}$	-	63	-	S
<b>Dynamic <sup>b</sup></b>						
Input capacitance	$C_{iss}$	$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	-	3120	-	pF
Output capacitance	$C_{oss}$		-	280	-	
Reverse transfer capacitance	$C_{rss}$		-	24	-	
Total gate charge	$Q_g$	$V_{DS} = 100\text{ V}, V_{GS} = 10\text{ V}, I_D = 60\text{ A}$	-	58	87	nC
Gate-source charge	$Q_{gs}$		-	17.6	-	
Gate-drain charge	$Q_{gd}$		-	17.2	-	
Output charge	$Q_{oss}$	$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}$	-	108	162	
Gate resistance	$R_g$	$f = 1\text{ MHz}$	1.5	3	5	$\Omega$
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 100\text{ V}, R_L = 1.66\text{ }\Omega, I_D \cong 60\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\text{ }\Omega$	-	14	28	ns
Rise time	$t_r$		-	125	250	
Turn-off delay time	$t_{d(off)}$		-	27	54	
Fall time	$t_f$		-	80	150	
<b>Drain-Source Body Diode Characteristics</b>						
Pulse diode forward current ( $t = 100\text{ }\mu\text{s}$ )	$I_{SM}$		-	-	240	A
Body diode voltage	$V_{SD}$	$I_F = 30\text{ A}, V_{GS} = 0\text{ V}$	-	0.85	1.5	V
Body diode reverse recovery time	$t_{rr}$	$I_F = 30\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}$	-	150	300	ns
Body diode reverse recovery charge	$Q_{rr}$		-	0.9	1.8	nC
Reverse recovery fall time	$t_a$		-	125	-	ns
Reverse recovery rise time	$t_b$		-	25	-	
Body diode peak reverse recovery charge	$I_{RM(REC)}$		-	11.5	20	A

**Notes**

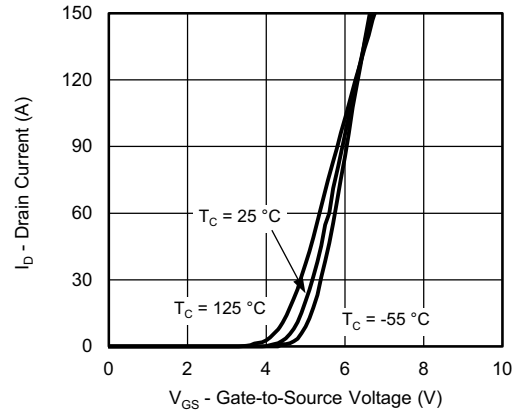
- Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- Guaranteed by design, not subject to production testing.
- Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

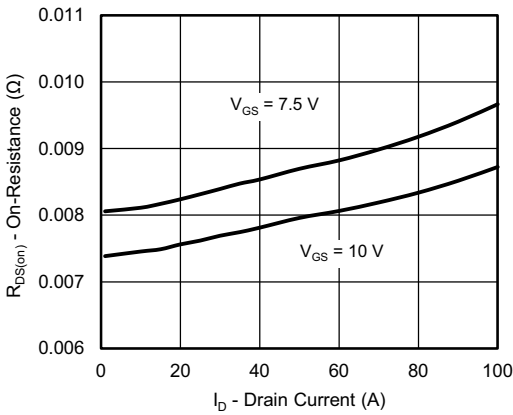
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



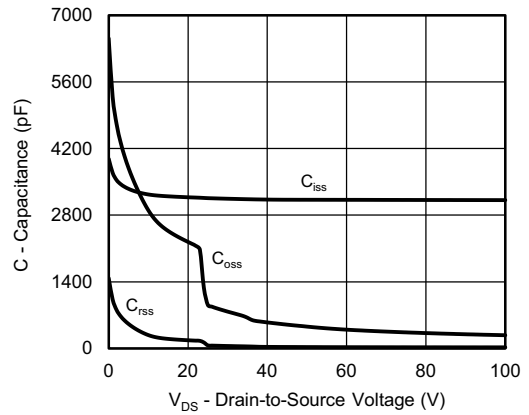
**Output Characteristics**



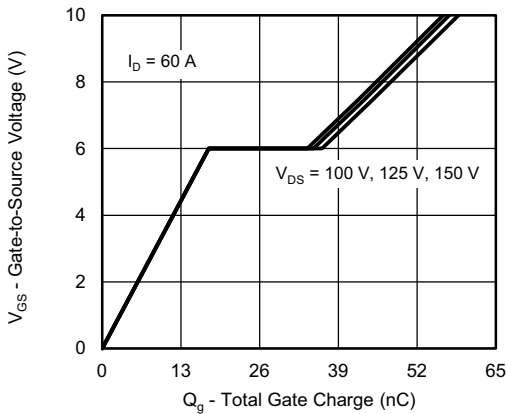
**Transfer Characteristics**



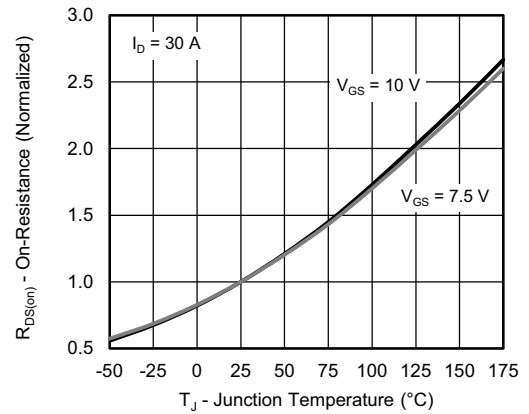
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**

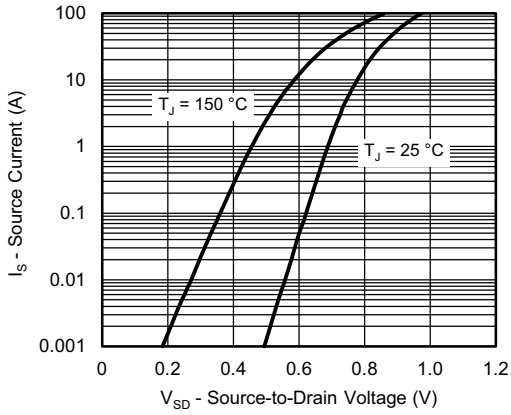


**Gate Charge**

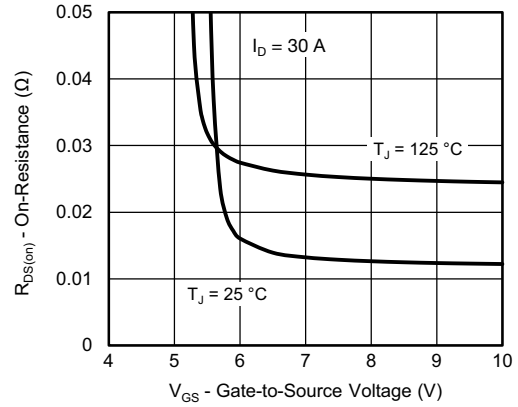


**On-Resistance vs. Junction Temperature**

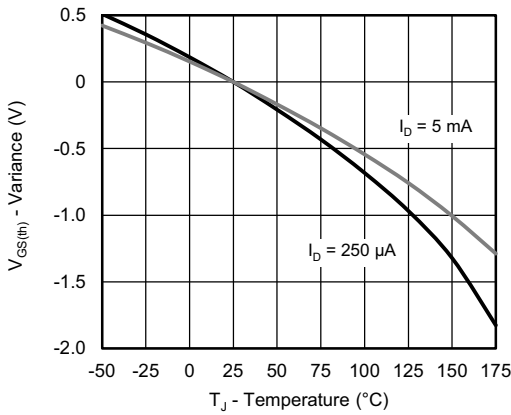
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



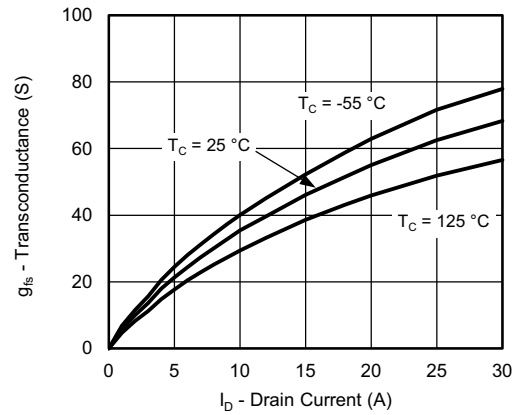
**Source-Drain Diode Forward Voltage**



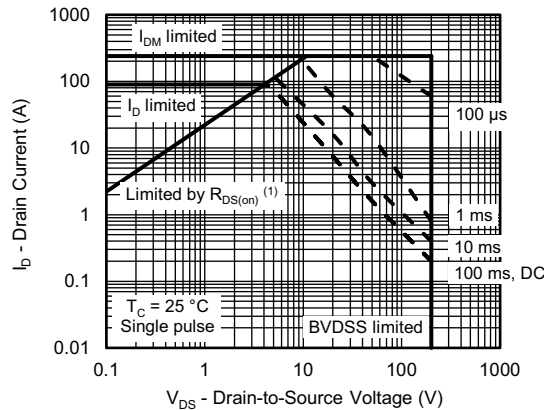
**On-Resistance vs. Gate-to-Source Voltage**



**Threshold Voltage**



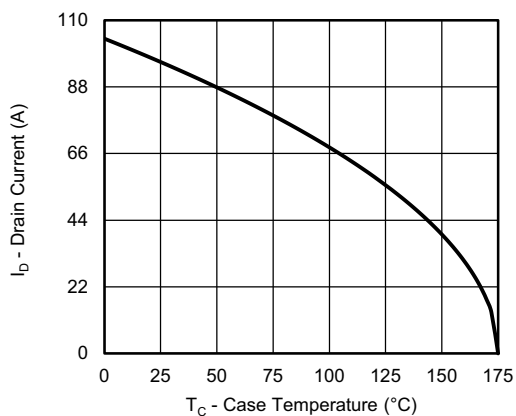
**Transconductance**



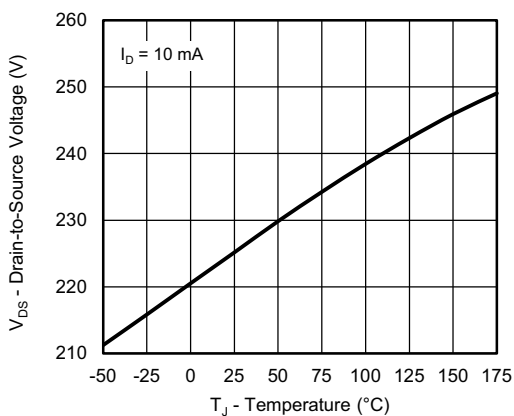
(1)  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

**Safe Operating Area, Junction-to-Ambient**

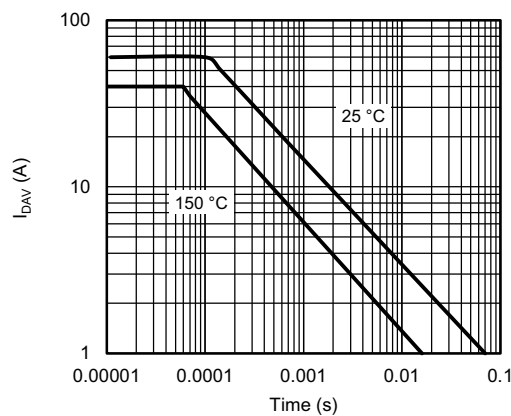
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



**Current Derating<sup>a</sup>**



**Drain Source Breakdown vs. Junction Temperature**

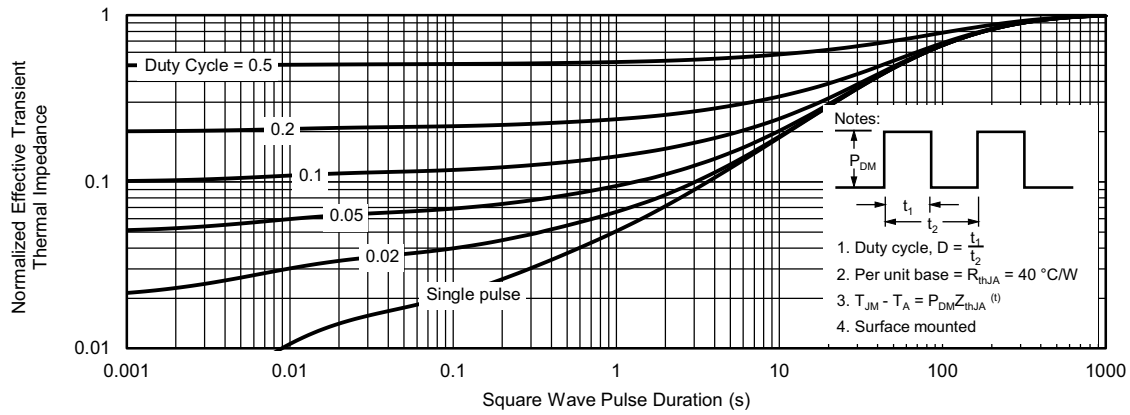


**$I_{DAV}$  vs. Time**

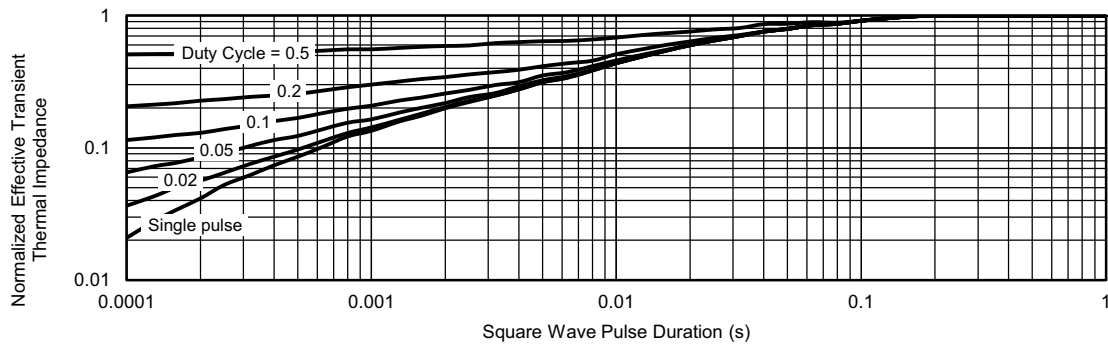
**Note**

- a. The power dissipation  $P_D$  is based on  $T_J$  max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Case**

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